

Notice of References Cited	Application/Control No. 10/840,100		Applicant(s)/Patent Under Reexamination CHEN, HSIN-LIANG	
	Examiner Bobbak Safaipoor		Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,652,766 A	07-1997	Matsumura et al.	375/295
*	B	US-2002/0090970 A1	07-2002	Ko, Moon-Jung	455/550
*	C	US-2002/0128053 A1	09-2002	Jung, Kwang Shin	455/575
*	D	US-2004/0023684 A1	02-2004	Sato et al.	455/550.1
*	E	US-2004/0067784 A1	04-2004	Kubo et al.	455/575.4
*	F	US-2004/0203525 A1	10-2004	Gillette et al.	455/090.3
*	G	US-2005/0043056 A1	02-2005	Boesen, Peter V.	455/550.1
*	H	US-2005/0124396 A1	06-2005	Brems et al.	455/575.4
*	I	US-2005/0221873 A1	10-2005	Kameyama et al.	455/575.4
*	J	US-7,107,084 B2	09-2006	Duarte et al.	455/575.3
*	K	US-2006/0234786 A1	10-2006	Taniguchi et al.	455/575.4
*	L	US-2001/0019946 a1	09-2001	Okuda, Tatsumi	455/90
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.